## Notice of References Cited

Application/Control No. 10/010,412

Applicant(s)/Patent Under Reexamination SHIRLEY ET AL.

Examiner
Paul L Rodriguez

Art Unit 2121

Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0047222	<del>01</del> -2001	Wiesler et al.	700/214
	В	US-6,334,209	12-2001	Hashimoto et al.	378/35
	С	US-6,240,335	05-2001	Wehrung et al.	198/571
<u> </u>	D	US-6,157,866	12-2000	Conboy et al.	414/940
<u> </u>	E	US-6,136,614	10-2000	Funk, Kevin K.	438/14
	F	US-6,112,130	08-2000	Fukuda et al.	700/105
-	G	US-5,972,727	10-1999	Ryan et al.	250/548
	н	US-5,231,585	07-1993	Kobayashi et al.	700/112
	1	US-5,191,535	03-1993	Terao, Haruo	216/48
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	a					
	R					
	s				`	
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.